Structure of 1,3-Bis(1-pyrenyl)hexamethyltrisilane

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Abstract

The trisilane chain C(1)—Si(1)—Si(2)—Si(3)—C(1B) adopts a – anticlinal, + synclinal conformation. The pyrene rings are slightly folded and make and angle of 71° to each other.

Comment

The structure determination of the title compound was undertaken to establish the mutual orientation of the pyrene rings. Details of the spectroscopic properties of dipyrenyl-substituted oligosilanes are reported by Declercq, De Schryver & Miller (1991).



The final atomic coordinates and equivalent isotropic temperature factors are listed in Table 1. The molecular structure with labelling is depicted in Fig. 1. Bond distances and selected bond angles are listed in Table 2.

The trisilane chain adopts a -anticlinal [C(1B)-Si(1)-Si(2)-Si(3) = -117.6 (2)°], + synclinal [Si(1)-Si(2)-Si(3)-C(1) = 62.8 (2)°] conformation, with the pyrene rings almost perpendicular to each other. The angle between the best planes through the pyrene atoms is 71°. Both pyrene rings are slightly folded, significantly more than found in the crystal structure of pyrene (Hazell, Larsen & Lehmann,

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Fig. 1. View of the molecule with labelling. Thermal ellipsoids are shown at 50% probability levels; H atoms are drawn as small circles of arbitrary radius (*SHELXTL PC*, Sheldrick 1990).

1972). The maximum deviation from the best plane through the pyrene atoms is 0.055 Å for ring A and -0.047 Å for ring B, compared with -0.020 Å for pyrene. Both pyrene rings show a very short C(4)—C(5) bond distance of 1.331 (8) Å (ring A) and 1.329 (6) Å (ring B).

A search in the January 1992 version of the Cambridge Structural Database (Allen, Kennard & Taylor, 1983) revealed two comparable 1,8-bis(1-pyrenyl)naphthalenes (*cis* and *trans*; Wahl, Krieger, Schweitzer & Staab, 1984). Here the trisilane chain is replaced by a planar Csp^2 — Csp^2 — Csp^2 chain bringing the two pyrene planes parallel to each other.

Experimental

Crystal data	
C ₃₈ H ₃₆ Si ₃	λ = 1.54178 Å
$M_r = 576.9$	Cell parameters from 30
Monoclinic	reflections
$P2_1/c$	$\theta = 4 - 13^{\circ}$
a = 11.213 (2) Å b = 22.656 (4) Å c = 13.397 (3) Å $\beta = 110.70 (1)^{\circ}$ $V = 3183.7 (11) \text{ Å}^{3}$	$\mu = 1.522 \text{ mm}^{-1}$ T = 289 K Parallelepiped $0.4 \times 0.3 \times 0.3 \text{ mm}$ Colourless with yellow fluorescence
Z = 4	Crystal source: crystallized
$D_x = 1.204 \text{ Mg m}^{-3}$ Cu $K\alpha$ radiation	by evaporation from cy- clohexane

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Data collection	Table 2. Geometric parameters (Å, °)				
Siemens P4/PC diffractome-	3459 observed reflections: [E > 4.0 = (E)]	Si(1)—Si(2)	2.355 (2)	Si(1)—C(17)	1.890 (4)
	[r > 4.00(r)]	Si(1) - C(18)	1.875 (5)	Si(1)— $C(1B)$	1.892 (4)
$2\theta - \theta$ scans	$R_{\rm int} = 0.0365$	Si(2)—Si(3)	2.356 (2)	Si(2)C(19)	1.906 (4)
Absorption correction:	$\theta_{\rm max} = 58^{\circ}$	Si(2)—C(20)	1.881 (5)	Si(3)—C(21)	1.886 (6)
Semi-empirical	$h = 0 \rightarrow 12$	Si(3)—C(22)	1.883 (5)	Si(3) - C(1)	1.891 (3)
T = 0.5655 $T = 0.5655$	$k = 0 \longrightarrow 24$	C(1B) - C(2B)	1.403 (6)	C(1B) - C(14B)	1.411 (4)
$I_{\rm min} = 0.3033, I_{\rm max} = 0.0000$	$k = 0 \rightarrow 24$	C(2B) - C(3B)	1.376 (6)	C(3B) - C(11B)	1.384 (5)
0.0090	$l = -14 \rightarrow 13$	C(4B) - C(5B)	1.329 (6)	C(4B) - C(11B)	1.434 (6)
4606 measured reflections	3 standard reflections	C(5B) = C(12B)	1.431 (6)	C(6B) - C(7B)	1.377 (7)
4352 independent reflections	monitored every 50	C(BB) = C(12B)	1.389 (6)	C(7B) - C(8B)	1.376 (7)
r	reflections	C(8B) - C(13B)	1.396 (5)	C(9B) - C(10B)	1.341 (5)
	intensity variation, none	C(3B) = C(15B)	1.429 (5)	C(10B) - C(14B)	1.431 (5)
	intensity variation. none	C(11B) - C(15B)	1.429 (5)	C(12B) = C(16B)	1.420 (5)
Refinement		C(15B) - C(16B)	1.419 (5)	C(14B) = C(15B)	1.422 (5)
-		C(1) = C(10B)	1.427 (4)	C(1) = C(2)	1.402 (6)
Refinement on F	Unit weights applied	C(1) = C(14)	1.400 (3)	C(2) = C(3)	1.381 (5)
Final $R = 0.0424$	$(\Lambda/\sigma) = 0.081$	C(3) = C(11)	1.362 (0)	C(4) = C(3)	1.331 (8)
wR = 0.0451	$(23/0)_{\text{max}} = 0.081$	C(4) = C(7)	1.442 (3)	C(3) = C(12)	1.415 (7)
S = 1.23	$\Delta \rho_{\rm max} = 0.37 \ {\rm e} \ {\rm \AA}^{-3}$	C(7) = C(8)	1.372 (9)	C(0) = C(12)	1.398 (8)
3 - 1.23	$A = -0.17 - \lambda^{-3}$	C(9) = C(10)	1.378 (7)	C(0) = C(13)	1.399 (0)
3459 reliections	$\Delta \rho_{\rm min} = -0.17 {\rm e A}^{-1}$	C(10) - C(14)	1.344(5)	C(1) = C(15)	1.434 (3)
406 parameters	Atomic scattering factors	C(12) - C(16)	1 428 (5)	C(13) = C(15)	1.414 (0)
Only H-atom U's refined	from International Tables	C(14)C(15)	1.429 (4)	C(15) = C(16) C(15) = C(16)	1.420 (0)
[riding model (CH =	for X-ray Crystallography	Si(2) - Si(1) - C(17)	107.5 (2)	Si(2) - Si(1) - C(18)	111 5 (2)
0.96 A)]	(1974, Vol. IV)	C(17) - Si(1) - C(18)	107.1 (3)	Si(2) - Si(1) - C(1B)	1125(1)
		C(17) - Si(1) - C(1B)	108.2 (2)	C(18) - Si(1) - C(1B)	109.9 (2)
Table 1 Frantianal stamic secondinates and such that		Si(1) - Si(2) - Si(3)	112.2 (1)	Si(1) - Si(2) - C(19)	107.8 (2)
raute 1. Fractional alomic	coordinates and equivalent	Si(3)—Si(2)—C(19)	104.4 (2)	Si(1) - Si(2) - C(20)	111.3 (2)
isotropic thermal parameters $(Å^2)$		Si(3)—Si(2)—C(20)	113.5 (1)	C(19) - Si(2) - C(20)	106.9 (2)
-		Si(2) - Si(3) - C(21)	109 4 (2)	Si(2) - Si(3) - C(22)	108 1 (2)

 $U_{eq} = 1/3$ (trace of the orthogonalized U_{ij} matrix).

	x	у	z	U_{eq}
Si(1)	0.5706(1)	0.3922 (1)	0.7183(1)	0.058 (1)
Si(2)	0.4217 (1)	0.3735 (1)	0.8019 (1)	0.055 (1)
Si(3)	0.4712 (1)	0.2875 (1)	0.9076(1)	0.057 (1)
C(17)	0.4796 (6)	0.3965 (3)	0.5699 (3)	0.097 (3)
C(18)	0.6881 (4)	0.3303 (2)	0.7406 (4)	0.085 (3)
C(19)	0.2619 (4)	0.3564 (3)	0.6933 (4)	0.099 (2)
C(20)	0.3971 (4)	0.4405 (2)	0.8755 (3)	0.074 (2)
C(21)	0.3373 (4)	0.2707 (2)	0.9576 (4)	0.079 (2)
C(22)	0.4781 (5)	0.2238 (2)	0.8196 (4)	0.086 (2)
C(1 <i>B</i>)	0.6581 (3)	0.4644 (2)	0.7626 (3)	0.053 (1)
C(2B)	0.6524 (4)	0.5076 (2)	0.6860 (3)	0.065 (2)
C(3B)	0.7124 (4)	0.5614 (2)	0.7126 (3)	0.068 (2)
C(4B)	0.8429 (4)	0.6319 (2)	0.8492 (4)	0.075 (2)
C(5B)	0.9083 (4)	0.6450 (2)	0.9506 (4)	0.079 (2)
C(6B)	0.9922 (4)	0.6152 (2)	1.1407 (4)	0.080 (2)
C(7 <i>B</i>)	1.0063 (4)	0.5734 (2)	1.2186 (4)	0.083 (2)
C(8B)	0.9532 (4)	0.5181 (2)	1.1930 (3)	0.071 (2)
C(9B)	0.8208 (3)	0.4479 (2)	1.0565 (3)	0.061 (2)
C(10B)	0.7496 (3)	0.4358 (2)	0.9549 (3)	0.056 (2)
C(11 B)	0.7814 (3)	0.5760 (2)	0.8175 (3)	0.058 (2)
C(12B)	0.9228 (3)	0.6032 (2)	1.0342 (3)	0.063 (2)
C(13B)	0.8817 (3)	0.5038 (2)	1.0874 (3)	0.054 (1)
C(14B)	0.7315 (3)	0.4772 (2)	0.8700 (3)	0.049(1)
C(15B)	0.7924 (3)	0.5329 (2)	0.8982 (3)	0.049 (1)
C(16 B)	0.8659 (3)	0.5467 (2)	1.0065 (3)	0.051 (1)
C(1)	0.6281 (3)	0.2907 (2)	1.0232 (3)	0.053 (1)
C(2)	0.7301 (4)	0.2549 (2)	1.0226 (3)	0.064 (2)
C(3)	0.8447 (4)	0.2537 (2)	1.1072 (4)	0.070 (2)
C(4)	0.9814 (4)	0.2870 (2)	1.2885 (4)	0.082 (2)
C(5)	0.9989 (4)	0.3215 (2)	1.3729 (4)	0.091 (2)
C(6)	0.9218 (6)	0.4005 (3)	1.4631 (4)	0.107 (3)
C(7)	0.8272 (6)	0.4385 (3)	1.4645 (4)	0.119 (3)
C(8)	0.7116 (5)	0.4401 (2)	1.3815 (3)	0.092 (2)
C(9)	0.5711 (4)	0.4033 (2)	1.2048 (3)	0.062 (2)
C(10)	0.5525 (3)	0.3676 (2)	1.1206 (3)	0.054 (1)
C(11)	0.8645 (3)	0.2876 (2)	1.1973 (3)	0.063 (2)
C(12)	0.9046 (4)	0.3616 (2)	1.3781 (3)	0.081 (2)
C(13)	0.6892 (4)	0.4027 (2)	1.2937 (3)	0.066 (2)
C(14)	0.6481 (3)	0.3269 (2)	1.1129 (3)	0.051 (1)
C(15)	0.7662 (3)	0.3257 (2)	1.2010 (3)	0.054 (1)
C(16)	0.7862 (4)	0.3632 (2)	1.2905 (3)	0.062 (2)

Data collection, data reduction and absorption correction: Siemens P3/PC software (Siemens Analytical X-ray Instruments, Inc., 1989). The program package SHELXTL PC (Sheldrick, 1990) was used for all calculations and figures. Refinement was by full-matrix least-squares methods.

Si(2)—Si(3)—C(1)

C(22)-Si(3)-C(1)

Si(3)-C(1)-C(14)

Si(1) - C(1B) - C(14B)

114.5 (1)

108.0 (2)

123.2 (3)

122.9 (3)

106.4 (2)

110.1 (2)

119.3 (2)

119.9 (3)

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Lists of structure factors, anisotropic thermal parameters, H-atom coordinates and complete geometry have been deposited with the British Library Document Supply Centre as Supplementary Publication No. SUP 55696 (18 pp.). Copies may be obtained through The Technical Editor, International Union of Crystallography, 5 Abbey Square, Chester CH1 2HU, England. [CIF reference: NA1013]

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C(21)-Si(3)-C(22)

C(21)-Si(3)-C(1)

Si(3) - C(1) - C(2)

Si(1)-C(1B)-C(2B)

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Structure of the Photostable Form of p-Nitrocinnamic Acid

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Abstract

The molecule is planar to within 0.08 (2) Å. The molecules form a centrosymmetric dimer through O-H.O hydrogen bonds between the carboxylic groups. The dimers are stacked along **b** with an interplanar distance of 3.374 (2) Å. The C=C double bonds of the nearest neighbors are related by a b translation.

Comment

The structure of the photostable form of pnitrocinnamic acid has been determined as part of studies into solid-state photoreactions (Iwamoto, Kashino & Haisa, 1989). The lattice parameters and space groups of the photostable and photoreactive forms of the title compound have been reported by Schmidt (1964). The crystals used in the present study were obtained by slow evaporation from an ethanol solution. The crystal structure is similar to

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Fig. 1. The thermal ellipsoids with atomic numbering. Ellipsoids are drawn at 50% probability for the non-H atoms; the H atoms are represented as spheres equivalent to $B = 1.0 \text{ A}^2$.

that of photoreactive *p*-formylcinnamic acid (Nakanishi, Hasegawa & Mori, 1985). However, the length of the b axis is 0.206 Å longer than in pformylcinnamic acid.

Cu $K\alpha$ radiation

Cell parameters from 18 reflections

 $0.28 \times 0.28 \times 0.15$ mm

 $\lambda = 1.54178 \text{ Å}$

 $\mu = 1.06 \text{ mm}^{-1}$

 $\theta = 8 - 18^{\circ}$

T = 295 K

Prismatic

Colorless

 $\theta_{\rm max}$ = 62.5°

3 standard reflections

monitored every 57

intensity variation: 1%

Experimental

Crystal data C₉H₇NO₄ $M_r = 193.16$ Monoclinic $P2_1/a$ a = 27.729 (5) Å *b* = 5.0311 (7) Å c = 6.105 (1) Å $\beta = 99.57 \ (2)^{\circ}$ V = 839.9 (3) Å³ Z = 4 $D_x = 1.527 \text{ Mg m}^{-3}$ $D_m = 1.50 \text{ Mg m}^{-3}$

Data collection

Rigaku AFC-5 diffractome-	$\theta_{\rm max} = 62.5^{\circ}$
ter	$h = -31 \rightarrow 30$
ω -2 θ scans	$k = 0 \rightarrow 5$
1548 measured reflections	$l = 0 \rightarrow 6$
1329 independent reflections	3 standard refle
1284 observed reflections	monitored ev
$[F_o > 1\sigma(F_o)]$	reflections
$R_{\rm int} = 0.011$ for 138 hk0	intensity vari
reflections	

Refinement

O(1) O(2) O(3) O(4)

N(1)

C(1)

C(2) C(3) C(4)C(5) C(6)

C(7)

C(8)

C(9)

Refinement on F	$w = 1/[\sigma(F_o)^2 - 0.4488 F_o $
Final $R = 0.045$	$+0.0228 F_o ^2$]
wR = 0.055	$(\Delta/\sigma)_{\rm max} = 0.23$
S = 2.91	$\Delta \rho_{\rm max} = 0.2 \ {\rm e} \ {\rm \AA}^{-3}$
1284 reflections	$\Delta \rho_{\rm min} = -0.3 \ {\rm e} \ {\rm \AA}^{-3}$
156 parameters	Atomic scattering factors
All H-atom parameters re-	from International Tables
fined	for X-ray Crystallography
	(1974, Vol. IV)

Table 1. Fractional atomic coordinates and equivalent isotropic thermal parameters $(Å^2)$

$B_{\rm eq} = (4/3) \Sigma_i \beta_{ii} / a_{ii}^{*^-}$.			
x	у	z	Beq
0.50023 (4)	1.3330 (2)	0.2491 (2)	4.57 (5)
0.45399 (4)	1.2762 (2)	-0.0802 (2)	4.36 (5)
0.30860 (4)	-0.0074 (2)	0.6531 (2)	4.33 (5)
0.26096 (4)	-0.0400(2)	0.3379 (2)	4.05 (5)
0.29527 (4)	0.0591 (2)	0.4595 (2)	3.09 (5)
0.32246 (5)	0.2730 (3)	0.3712 (2)	2.79 (5)
0.36232 (5)	0.3803 (3)	0.5065 (2)	3.43 (6)
0.38838 (5)	0.5765 (3)	0.4236 (2)	3.55 (6)
0.37501 (5)	0.6666 (3)	0.2051 (2)	2.89 (6)
0.33429 (5)	0.5554 (3)	0.0745 (2)	3.21 (6)
0.30776 (5)	0.3572 (3)	0.1563 (2)	3.12 (6)
0.40240 (5)	0.8759 (3)	0.1126 (2)	3.22 (6)
0.44095 (5)	1.0036 (3)	0.2189 (2)	3.60 (7)
0.46586 (5)	1.2160 (3)	0.1198 (2)	3.41 (6)

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